Gallium Nitride 50V, 700W, 2.5-2.7GHz RF Power Transistor

Description

The STCV27700BY4V is a 700-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 2.5-2.7GHz, **enabled by wide band VBW capability to support IBW up to 200MHz.**.

It can be configured as asymmetrical Doherty for 4G or 5G application, delivering 100 to 115W average power, according to normal 8 to 8.5dB back off.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

• Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance:

VDD = 50 Vdc, IDQA = 280 mA, VGSB = -5.9Vdc,

(1)Pulsed condition: 20us and 10%

(2)1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.

Frog	Pul	se CW Signal ⁽¹⁾		Pavg=50dBm WCDMA Signal ⁽²⁾			
Freq (GHz)	P1-Gain (dB)	P5 (dBm)	P5 (W)	Gp (dB)	η ₀ (%)	ACPR₅м (dBc)	
2.5	13.81	58.61	724	13.15	51.14	-35.62	
2.6	14.62	58.60	724	13.20	52.22	-33.78	
2.7	13.68	58.50	708	12.54	50.67	-35.02	

Recommended driver:

• Doherty (1 stage discrete solution): STBV27070C6

Applications

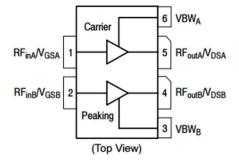
- Asymmetrical Doherty amplifier within N41 5G band and B41 4G band
- S band power amplifier

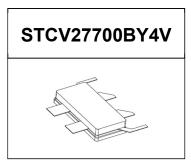
Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- 1. Set VGS to the pinch—off (VP) voltage, typically –5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

Figure 1: Pin Connection definition





Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

Table 1. Maximum Ratings

+200 -8 to +0.5 55	Vdc Vdc Vdc
55	Vdc
92	mA
-65 to +150	°C
+150	°C
	۵°
	+150 +225

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA	Balo	0.0	°C /W
T _c = 85°C, Pout=100W, 2.6GHz Doherty application board	Rejc	0.9	C /W

Table 3. Electrical Characteristics (TA = 25°C unless otherwise noted)

DC Characteristics (main path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=36mA	V _{DSS}		200		V
Gate Threshold Voltage	VDS =10V, ID = 36mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=280mA, Measured in Functional Test	V _{GS(Q)}		-3.1		V

DC Characteristics (peak path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=56mA	V _{DSS}		200		V
Gate Threshold Voltage	VDS =10V, ID = 56mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=450mA Measured in Functional Test	V _{GS(Q)}		-3.1		V

Ruggedness Characteristics

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Load mismatch capability	2.6GHz, Pout=100W WCDMA 1 Carrier in Doherty circuit All phase, No device damages	VSWR		10:1		

Figure 3: Efficiency and power gain as function of Pout (2.5-2.7GHz Doherty)

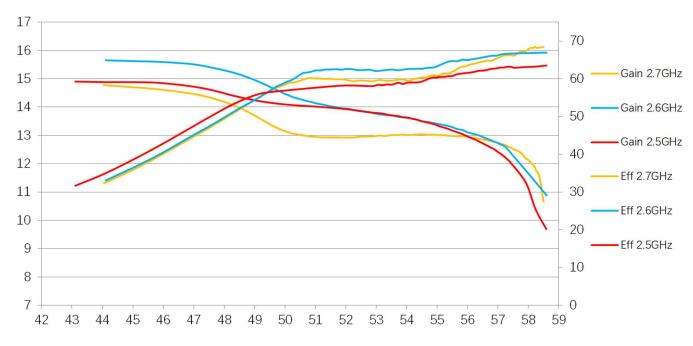


Figure 4: Network analyzer output, S11 and S21 (2.5-2.7GHz Doherty)

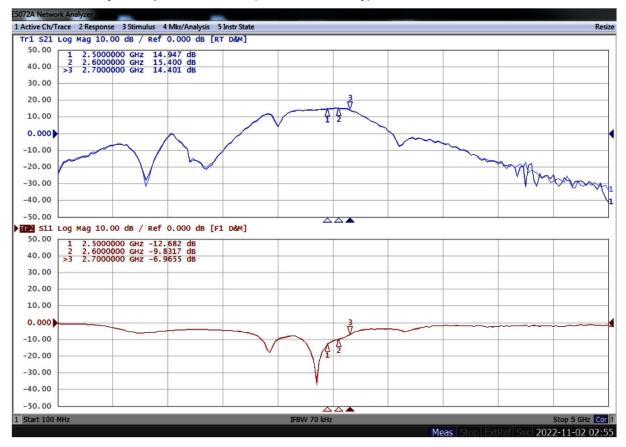
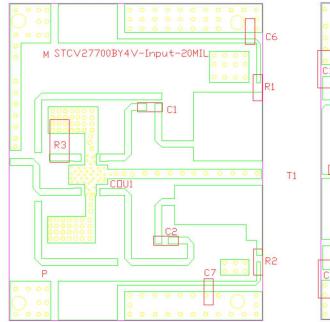


Figure 5: Picture of application board Doherty circuit for 2.5-2.7GHz



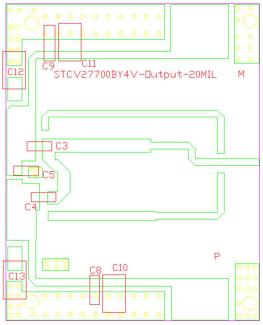
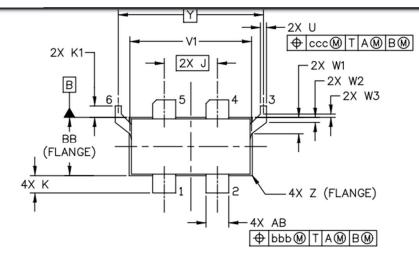


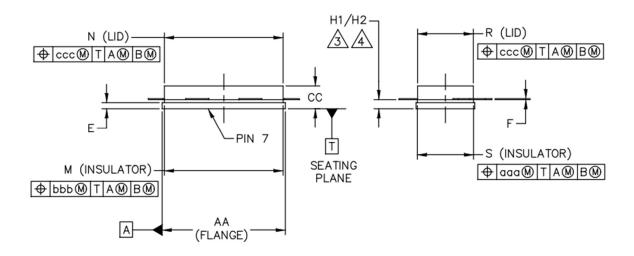
Table 4. Bill of materials of application board (PCB layout upon request, RO4350B 20mils)

Part	Quantity	Description	Part Number	Manufacturer
C1,C2,C4	7	10pFHigh Q	251SHS100BSE	TEMEX
C6,C7,C8,C9		Capacitor		
C3	1	6.8pFHigh Q	251SHS6R8BSE	TEMEX
		Capacitor		
C5	1	0.7pFHigh Q	251SHSOR7BSE	TEMEX
		Capacitor		
C10,C11,C12,C13	4	10uF MLCC	GRM32EC72A10	Murata
R1,R2	2	10 Ω Power Resistor	ESR03EZPF100	ROHM
R3	1	50 Ω Power Resistor	S1206N	RN2
COU1	1	3 dB Bridge	RCP2600Q03	RN2
T1	1	700W GaN	STCV27700BY4V	Innogration
		Dual Transistor		

Earless Flanged Ceramic Package; 6 leads- BY4V

Document Number: STCV27700BY4V Preliminary Datasheet V1.0





	IN	СН	MILLIN	IETER		IN	INCH		ETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
AA	.805	.815	20.45	20.70	R	.365	.375	9.27	9.53
BB	.380	.390	9.65	9.91	S	.365	.375	9.27	9.53
CC	.125	.170	3.18	4.32	U	.035	.045	0.89	1.14
E	.035	.045	0.89	1.14	V1	.795	.805	20.19	20.45
F	.004	.007	0.10	0.18	W1	.0975	.1175	2.48	2.98
H1	.057	.067	1.45	1.70	W2	.0225	.0425	0.57	1.08
H2	.054	.070	1.37	1.78	W3	.0125	.0325	0.32	0.83
J	.350	BSC	8.89 BSC		Y	.956	BSC	24.28	B BSC
к	.0995	.1295	2.53	3.29	Z	R.000	R.040	R0.00	R1.02
K1	.070	.090	1.78	2.29	AB	.145	.155	3.68	3.94
М	.774	.786	19.66	19.96	aaa		005	0.1	3
Ν	.772	.788	19.61	20.02	bbb	.010 0.2		25	
					ccc	.0)15	0.3	8

Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2022/11/3	V1.0	Preliminary Datasheet Creation

Application data based on LWH-22-12

Notice

Specifications are subject to change without notice. Innogration believes the information within the data sheet to be reliable. Innogration makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose.

"Typical" parameter is the average values expected by Innogration in quantities and are provided for information purposes only. It can and do vary in different applications and related performance can vary over time. All parameters should be validated by customer's technical experts for each application.

Innogration products are not designed, intended or authorized for use as components in applications intended for surgical implant into the body or to support or sustain life, in applications in which the failure of the Innogration product could result in personal injury or death or in applications for planning, construction, maintenance or direct operation of a nuclear facility.

For any concerns or questions related to terms or conditions, please check with Innogration and authorized distributors Copyright © by Innogration (Suzhou) Co.,Ltd.